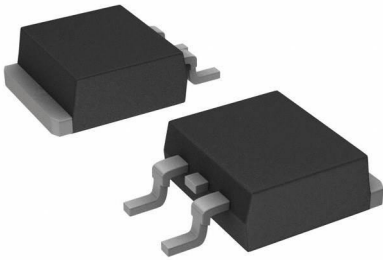


IRL2203STRR Datasheet

www.digi-electronics.com



<https://www.DiGi-Electronics.com>

| | |
|------------------------------|----------------------------------------------------------------------------|
| DiGi Electronics Part Number | IRL2203STRR-DG |
| Manufacturer | Vishay Siliconix |
| Manufacturer Product Number | IRL2203STRR |
| Description | MOSFET N-CH 30V 100A D2PAK |
| Detailed Description | N-Channel 30 V 100A (Tc) 3.8W (Ta), 130W (Tc) Surface Mount TO-263 (D2PAK) |



Tel: +00 852-30501935

RFQ Email: Info@DiGi-Electronics.com

DiGi is a global authorized distributor of electronic components.

Purchase and inquiry

Manufacturer Product Number:

IRL2203STRR

Series:

-

FET Type:

N-Channel

Drain to Source Voltage (Vdss):

30 V

Drive Voltage (Max Rds On, Min Rds On):

4V, 10V

Vgs(th) (Max) @ Id:

2.5V @ 250µA

Vgs (Max):

±20V

FET Feature:

-

Operating Temperature:

-55°C ~ 175°C (TJ)

Supplier Device Package:

TO-263 (D2PAK)

Base Product Number:

IRL2203

Manufacturer:

Vishay Siliconix

Product Status:

Discontinued at Digi-Key

Technology:

MOSFET (Metal Oxide)

Current - Continuous Drain (Id) @ 25°C:

100A (Tc)

Rds On (Max) @ Id, Vgs:

7mOhm @ 60A, 10V

Gate Charge (Qg) (Max) @ Vgs:

110 nC @ 4.5 V

Input Capacitance (Ciss) (Max) @ Vds:

3500 pF @ 25 V

Power Dissipation (Max):

3.8W (Ta), 130W (Tc)

Mounting Type:

Surface Mount

Package / Case:

TO-263-3, D2PAK (2 Leads + Tab), TO-263AB

Environmental & Export classification

RoHS Status:

RoHS non-compliant

REACH Status:

REACH Unaffected

HTSUS:

8541.29.0095

Moisture Sensitivity Level (MSL):

1 (Unlimited)

ECCN:

EAR99

International IOR Rectifier

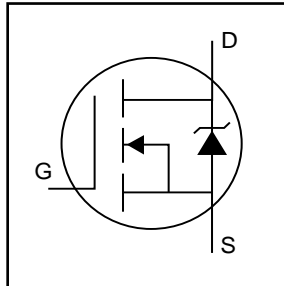
PRELIMINARY

PD 9.1091A

IRL2203S

HEXFET® Power MOSFET

- Logic-Level Gate Drive
- Surface Mount
- Advanced Process Technology
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated



$$V_{DSS} = 30V$$

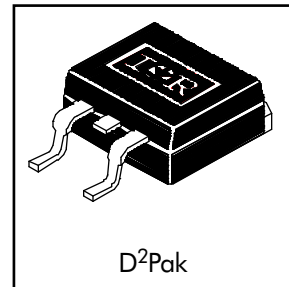
$$R_{DS(on)} = 0.007\Omega$$

$$I_D = 100A\textcircled{S}$$

Description

Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

The D²Pak is a surface mount power package capable of accommodating die sizes up to HEX-4. It provides the highest power capability and the lowest possible on-resistance in any existing surface mount package. The D²Pak is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0W in a typical surface mount application.

D²Pak

Absolute Maximum Ratings

| | Parameter | Max. | Units |
|---------------------------------|----------------------------------------------------------------|------------------------|-------|
| $I_D @ T_C = 25^\circ\text{C}$ | Continuous Drain Current, $V_{GS} @ 10V\textcircled{S}$ | 100 \textcircled{S} | A |
| $I_D @ T_C = 100^\circ\text{C}$ | Continuous Drain Current, $V_{GS} @ 10V\textcircled{S}$ | 71 | |
| I_{DM} | Pulsed Drain Current $\textcircled{1}\textcircled{S}$ | 400 | |
| $P_D @ T_A = 25^\circ\text{C}$ | Power Dissipation | 3.8 | W |
| $P_D @ T_C = 25^\circ\text{C}$ | Power Dissipation | 130 | W |
| | Linear Derating Factor | 0.83 | W/°C |
| V_{GS} | Gate-to-Source Voltage | ± 20 | V |
| E_{AS} | Single Pulse Avalanche Energy $\textcircled{2}\textcircled{S}$ | 390 | mJ |
| I_{AR} | Avalanche Current $\textcircled{1}$ | 60 | A |
| E_{AR} | Repetitive Avalanche Energy $\textcircled{1}$ | 13 | mJ |
| dv/dt | Peak Diode Recovery dv/dt $\textcircled{3}\textcircled{S}$ | 1.2 | V/ns |
| T_J | Operating Junction and | -55 to + 175 | °C |
| T_{STG} | Storage Temperature Range | | |
| | Soldering Temperature, for 10 seconds | 300 (1.6mm from case) | |

Thermal Resistance

| | Parameter | Typ. | Max. | Units |
|-----------------|----------------------------------------------------|------|------|-------|
| $R_{\theta JC}$ | Junction-to-Case | — | 1.2 | °C/W |
| $R_{\theta JA}$ | Junction-to-Ambient (PCB Mounted, steady-state)** | — | 40 | |

IRL2203S

International
RectifierElectrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

| | Parameter | Min. | Typ. | Max. | Units | Conditions |
|---------------------------------|--------------------------------------|------|-------|-------|---------|--------------------------------------------------------|
| $V_{(BR)DSS}$ | Drain-to-Source Breakdown Voltage | 30 | — | — | V | $V_{GS} = 0V, I_D = 250\mu A$ |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient | — | 0.035 | — | V/°C | Reference to 25°C , $I_D = 1\text{mA}$ ⑥ |
| $R_{DS(on)}$ | Static Drain-to-Source On-Resistance | — | — | 0.007 | | $V_{GS} = 10V, I_D = 60A$ ④ |
| | | — | — | 0.01 | | $V_{GS} = 4.5V, I_D = 50A$ ④ |
| $V_{GS(th)}$ | Gate Threshold Voltage | 1.0 | — | 2.5 | V | $V_{DS} = V_{GS}, I_D = 250\mu A$ |
| g_{fs} | Forward Transconductance | 47 | — | — | S | $V_{DS} = 25V, I_D = 60A$ ⑥ |
| I_{DSS} | Drain-to-Source Leakage Current | — | — | 25 | μA | $V_{DS} = 30V, V_{GS} = 0V$ |
| | | — | — | 250 | | $V_{DS} = 24V, V_{GS} = 0V, T_J = 150^\circ\text{C}$ |
| I_{GSS} | Gate-to-Source Forward Leakage | — | — | 100 | nA | $V_{GS} = 20V$ |
| | Gate-to-Source Reverse Leakage | — | — | -100 | | $V_{GS} = -20V$ |
| Q_g | Total Gate Charge | — | — | 110 | nC | $I_D = 60A$ |
| Q_{gs} | Gate-to-Source Charge | — | — | 31 | | $V_{DS} = 24V$ |
| Q_{gd} | Gate-to-Drain ("Miller") Charge | — | — | 57 | | $V_{GS} = 4.5V$, See Fig. 6 and 13 ④ ⑥ |
| $t_{d(on)}$ | Turn-On Delay Time | — | 15 | — | ns | $V_{DD} = 15V$ |
| t_r | Rise Time | — | 210 | — | | $I_D = 60A$ |
| $t_{d(off)}$ | Turn-Off Delay Time | — | 29 | — | | $R_G = 1.8\Omega, V_{GS} = 4.5V$ |
| t_f | Fall Time | — | 54 | — | | $R_D = 0.25\Omega$, See Fig. 10 ④ ⑥ |
| L_S | Internal Source Inductance | — | 7.5 | — | nH | Between lead, and center of die contact |
| C_{iss} | Input Capacitance | — | 3500 | — | pF | $V_{GS} = 0V$ |
| C_{oss} | Output Capacitance | — | 1400 | — | | $V_{DS} = 25V$ |
| C_{rss} | Reverse Transfer Capacitance | — | 690 | — | | $f = 1.0\text{MHz}$, See Fig. 5 ⑥ |

Source-Drain Ratings and Characteristics

| | Parameter | Min. | Typ. | Max. | Units | Conditions |
|----------|-------------------------------------------|------|------|-------|-------|-------------------------------------------------------------------------|
| I_S | Continuous Source Current (Body Diode) | — | — | 100 ⑤ | A | MOSFET symbol showing the integral reverse p-n junction diode. |
| I_{SM} | Pulsed Source Current (Body Diode) ① | — | — | 400 | | |
| V_{SD} | Diode Forward Voltage | — | — | 1.3 | V | $T_J = 25^\circ\text{C}, I_S = 60A, V_{GS} = 0V$ ④ |
| t_{rr} | Reverse Recovery Time | — | 94 | 140 | ns | $T_J = 25^\circ\text{C}, I_F = 60A$ |
| Q_{rr} | Reverse Recovery Charge | — | 280 | 410 | nC | $di/dt = 100A/\mu s$ ④ ⑥ |

Notes:

① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)

② $V_{DD} = 15V$, starting $T_J = 25^\circ\text{C}$, $L = 220\mu H$
 $R_G = 25\Omega, I_{AS} = 60A$. (See Figure 12)③ $I_{SD} \leq 60A, di/dt \leq 140A/\mu s, V_{DD} \leq V_{(BR)DSS}$,
 $T_J \leq 175^\circ\text{C}$ ④ Pulse width $\leq 300\mu s$; duty cycle $\leq 2\%$.

⑤ Calculated continuous current based on maximum allowable junction temperature; for recommended current-handling of the package refer to Design Tip # 93-4

⑥ Uses IRL2203N data and test conditions.

** When mounted on FR-4 board using minimum recommended footprint.
For recommended footprint and soldering techniques refer to application note #AN-994.

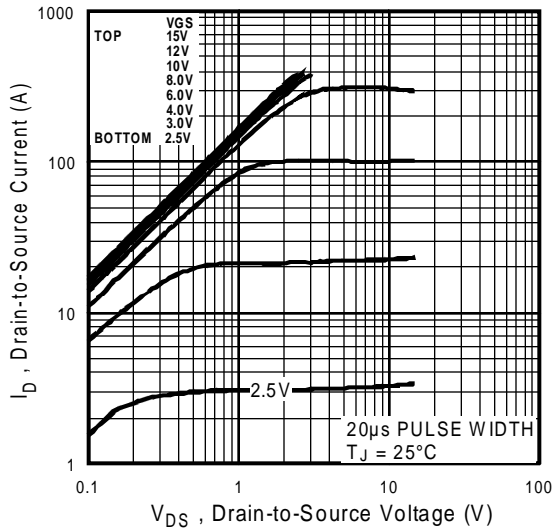


Fig 1. Typical Output Characteristics,
 $T_J = 25^\circ\text{C}$

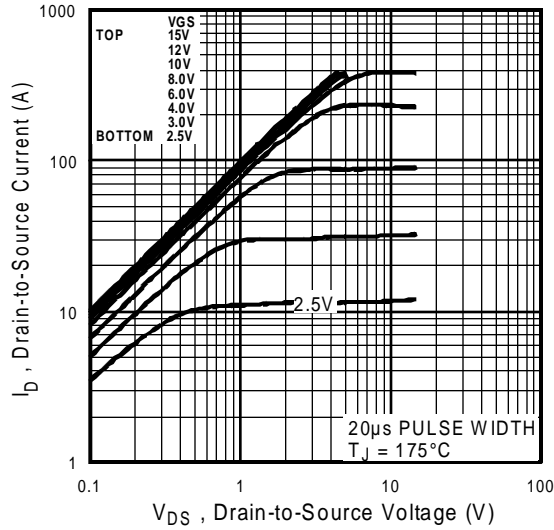


Fig 2. Typical Output Characteristics,
 $T_J = 175^\circ\text{C}$

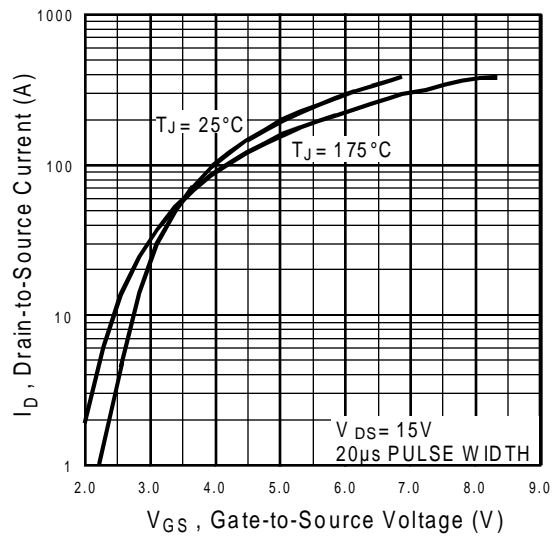


Fig 3. Typical Transfer Characteristics

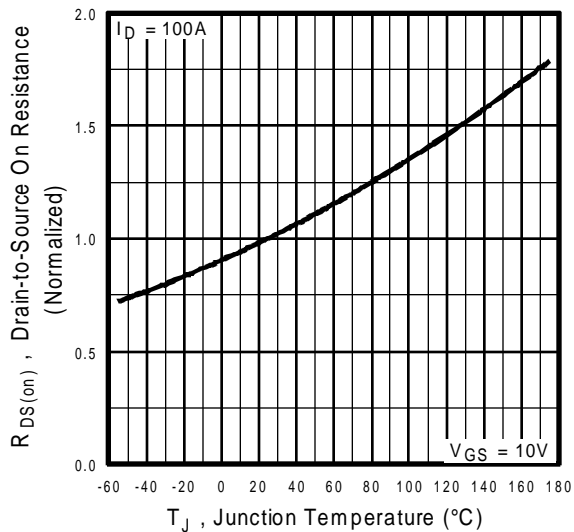


Fig 4. Normalized On-Resistance
 Vs. Temperature

IRL2203S

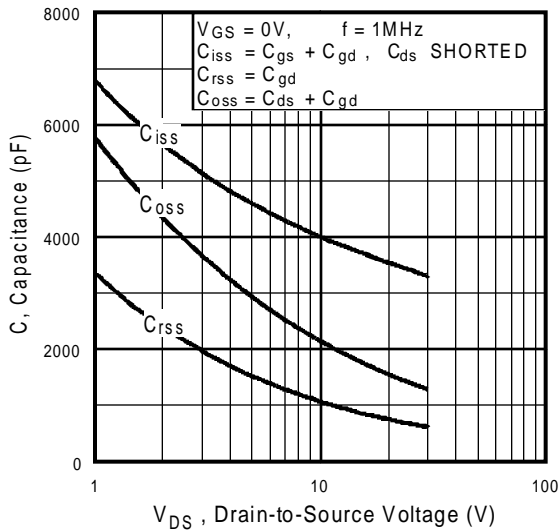


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

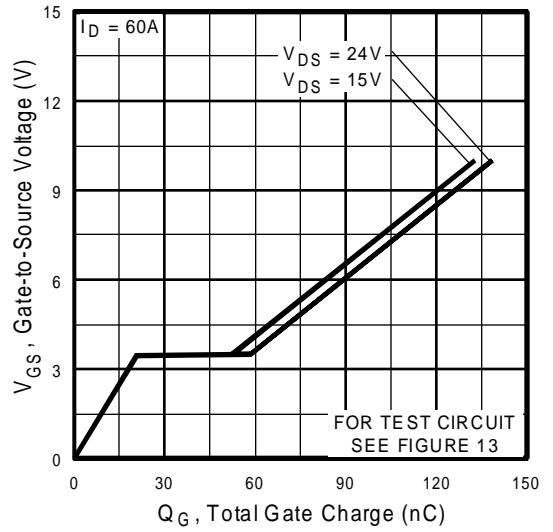


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

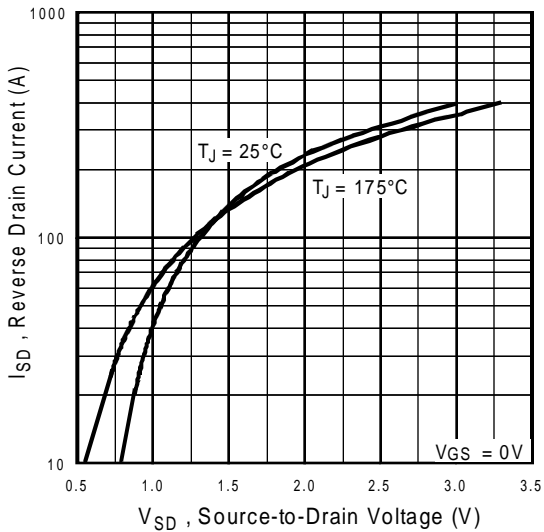


Fig 7. Typical Source-Drain Diode Forward Voltage

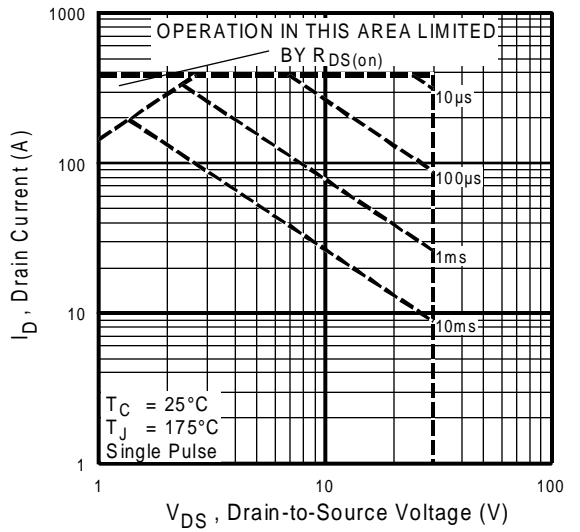


Fig 8. Maximum Safe Operating Area

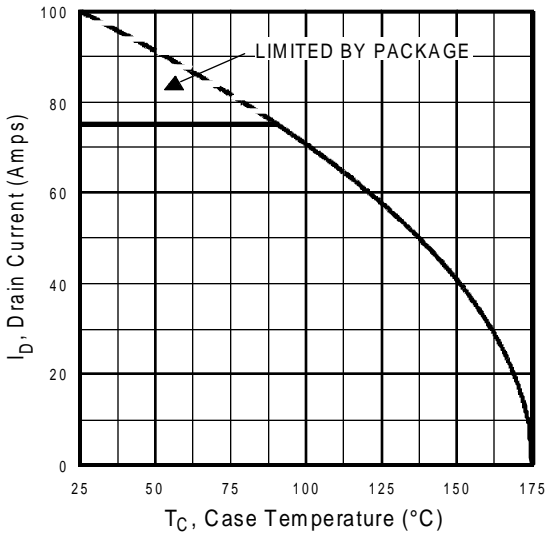


Fig 9. Maximum Drain Current Vs. Case Temperature

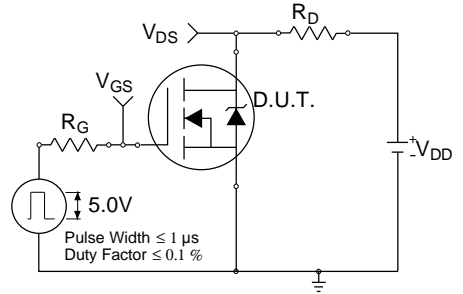


Fig 10a. Switching Time Test Circuit

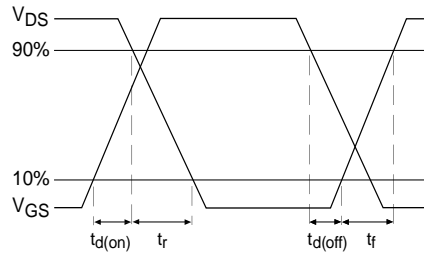


Fig 10b. Switching Time Waveforms

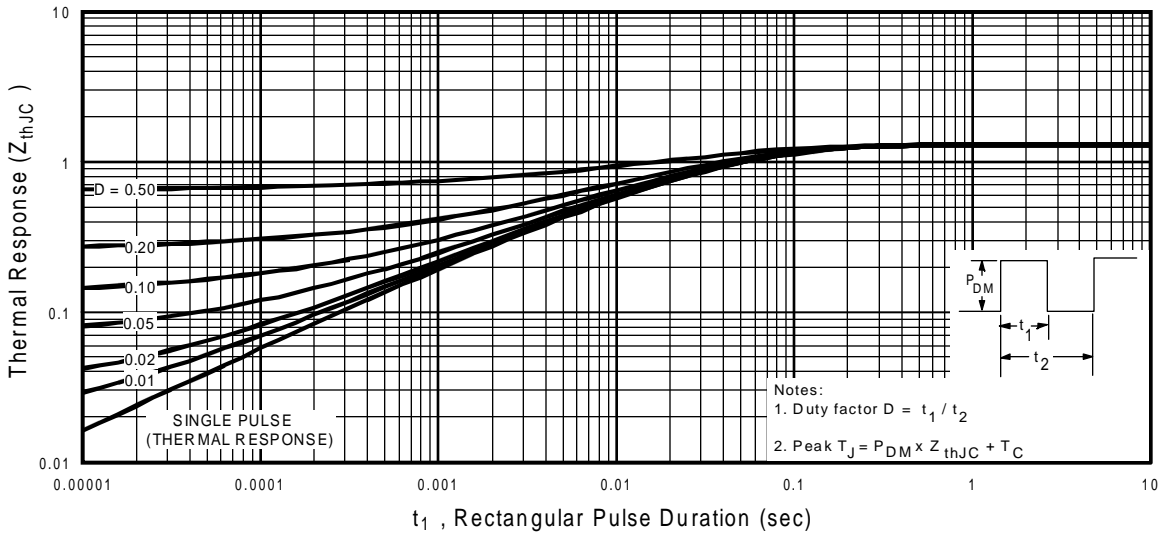


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

IRL2203S

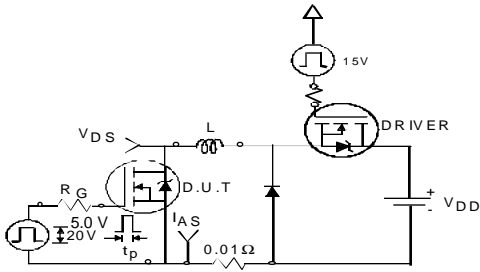


Fig 12a. Unclamped Inductive Test Circuit

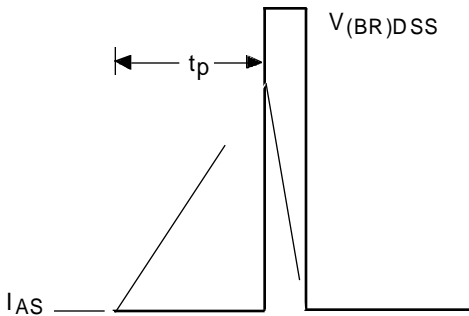


Fig 12b. Unclamped Inductive Waveforms

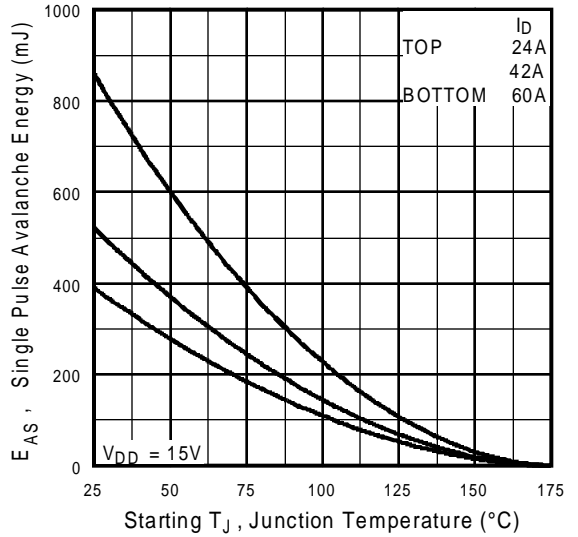


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

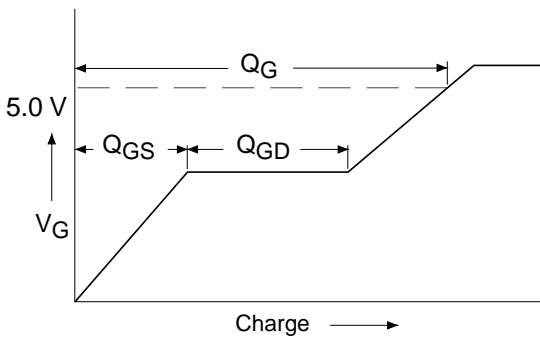


Fig 13a. Basic Gate Charge Waveform

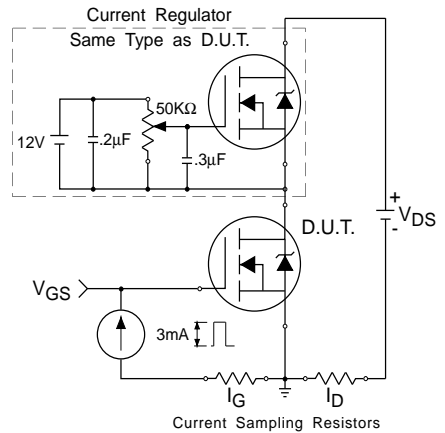
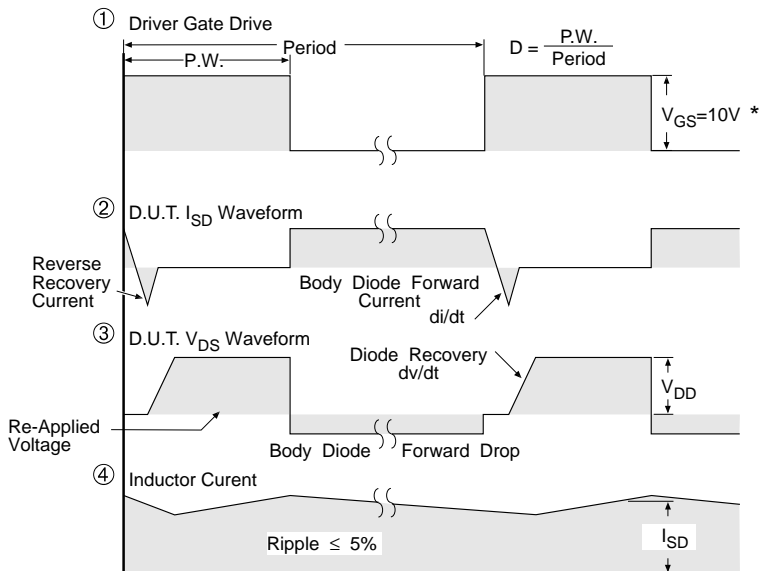
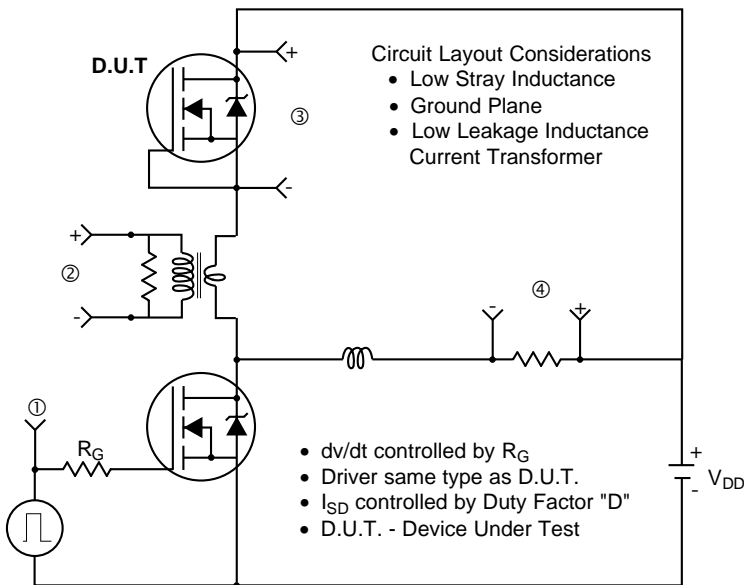


Fig 13b. Gate Charge Test Circuit

Peak Diode Recovery dv/dt Test Circuit



* $V_{GS} = 5V$ for Logic Level Devices

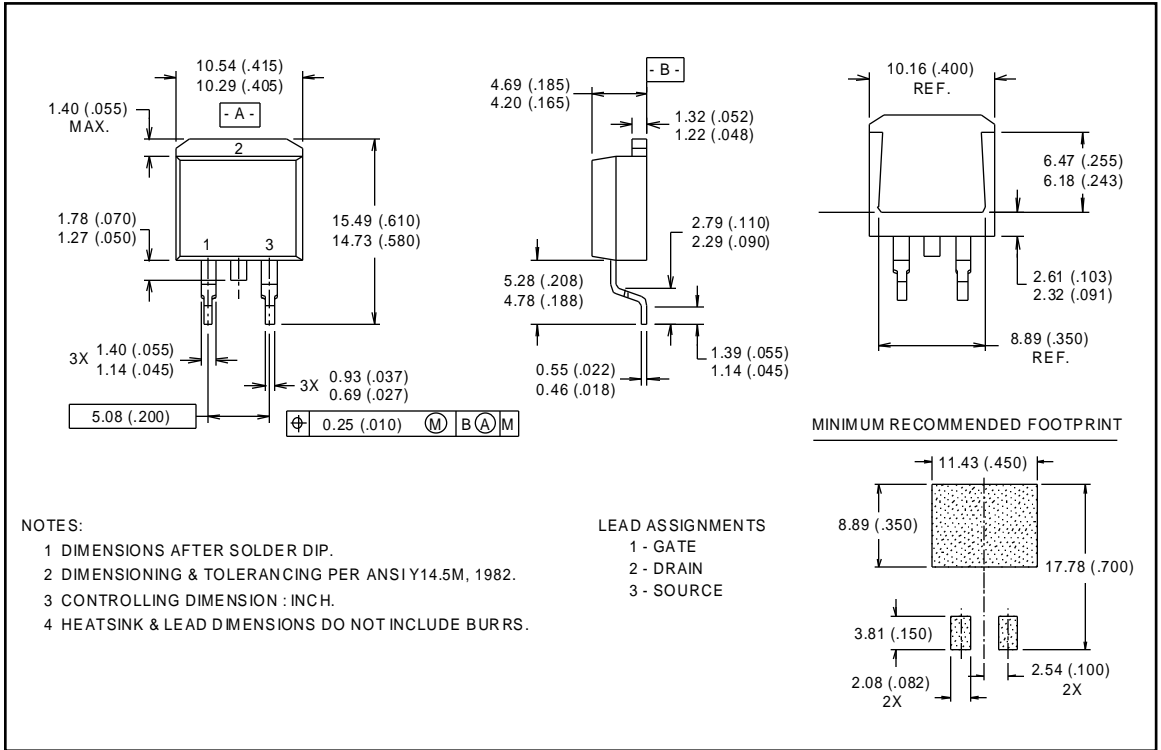
Fig 14. For N-Channel HEXFETS

IRL2203S



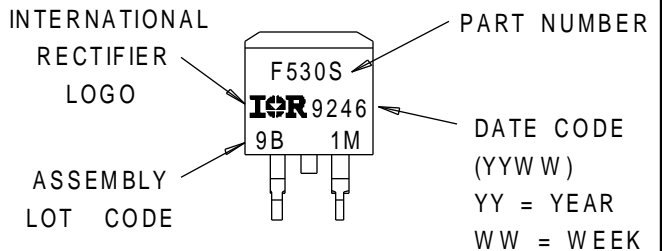
Package Outline — D²Pak

Dimensions are shown in millimeters (inches)



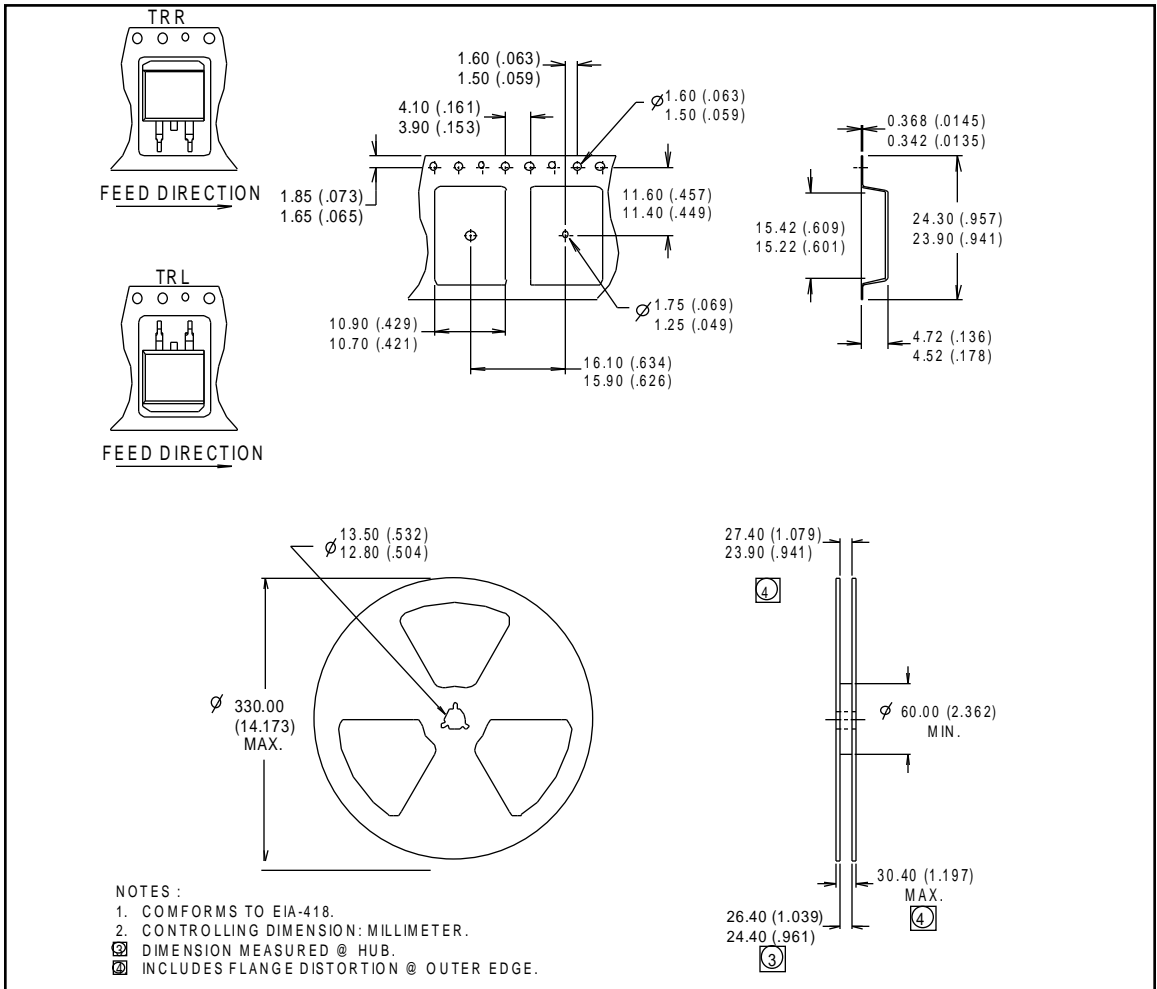
Part Marking

EXAMPLE : THIS IS AN IRF530S
WITH ASSEMBLY
LOT CODE 9B1M



Tape & Reel — D²Pak

Dimensions are shown in millimeters (inches)



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